

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/706,366	TSUDA, HIDEAKI	
Examiner (Nancy) Thanh-Nhan P. Nguyen		Art Unit 2871	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0231272	12-2003	Nakamura et al.	349/123
	B	US-6,621,550	09-2003	Arakawa et al.	349/178
	C	US-2002/0008836	01-2002	Shibahara, Hideo	349/155
	D	US-2001/0026347	10-2001	Sawasaki et al.	349/156
	E	US-5,729,318	03-1998	Yamada et al.	349/156
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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